

- Advanced Process Technology
- Optimized for Class D Audio Amplifier Applications
- Low $R_{ds(on)}$ for Improved Efficiency
- Low Q_g for Better THD and Improved Efficiency
- Low Q_{rr} for Better THD and Lower EMI
- Low Parasitic Inductance for Reduced Ringing and Lower EMI
- Delivers up to 250W per Channel into 4Ω with No Heatsink
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- Lead free, RoHS and Halogen free

Applicable DirectFET Outline and Substrate Outline ①

SB	SC			M2	M4		L4	L6	L8	
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Description

The AUIRF7675M2TR/TR1 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET packaging platform to produce a best in class part for Automotive Class D audio amplifier applications. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET Power MOSFET optimizes gate charge, body diode reverse recovery and internal gate resistance to improve key Class D audio amplifier performance factors such as efficiency, THD and EMI. Moreover the DirectFET packaging platform offers low parasitic inductance and resistance when compared to conventional wire bonded SOIC packages which improves EMI performance by reducing the voltage ringing that accompanies current transients.

These features combine to make this MOSFET a highly desirable component in Automotive Class D audio amplifier systems.

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	150	
V_{GS}	Gate-to-Source Voltage	± 20	V
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited) ④	18	
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited) ④	13	A
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited) ③	4.4	
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Package Limited)	90	
I_{DM}	Pulsed Drain Current ④	72	
$P_D @ T_C = 25^\circ C$	Power Dissipation ④	45	
$P_D @ T_A = 25^\circ C$	Power Dissipation ③	2.7	W
E_{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	59	mJ
$E_{AS}(\text{tested})$	Single Pulse Avalanche Energy Tested Value ⑤	170	
I_{AR}	Avalanche Current ①	See Fig.18a, 18b, 15, 16	A
E_{AR}	Repetitive Avalanche Energy ①		mJ
T_P	Peak Soldering Temperature	270	
T_J	Operating Junction and Storage Temperature Range	-55 to + 175	°C

Thermal Resistance

	Parameter	Typ.	Max.	Units
R_{0JA}	Junction-to-Ambient ③	—	60	
R_{0JA}	Junction-to-Ambient ⑧	12.5	—	
R_{0JA}	Junction-to-Ambient ⑨	20	—	°C/W
R_{0J-Can}	Junction-to-Can ④⑩	—	3.3	
R_{0J-PCB}	Junction-to-PCB Mounted	1.4	—	
	Linear Derating Factor ④⑩	0.3		W/°C

HEXFET® is a registered trademark of International Rectifier.

Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

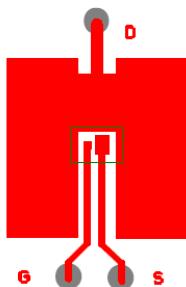
	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	150	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.16	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = 1\text{mA}$
$R_{\text{DS(on)}}$	Static Drain-to-Source On-Resistance	—	47	56	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$, $I_D = 11\text{A}$ ⑦
$V_{\text{GS(th)}}$	Gate Threshold Voltage	3.0	4.0	5.0	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = 100\mu\text{A}$
$\Delta V_{\text{GS(th)}}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-11	—	$\text{mV}/^\circ\text{C}$	
g_{fs}	Forward Transconductance	16	—	—	S	$V_{\text{DS}} = 50\text{V}$, $I_D = 11\text{A}$
R_G	Gate Resistance	—	1.2	5.0	Ω	
I_{DSS}	Drain-to-Source Leakage Current	—	—	20	μA	$V_{\text{DS}} = 150\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 150\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -20\text{V}$

Dynamic Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)

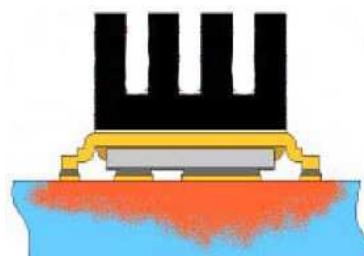
Q_g	Total Gate Charge	—	21	32	nC	$V_{\text{DS}} = 75\text{V}$ $V_{\text{GS}} = 10\text{V}$ $I_D = 11\text{A}$ See Fig. 6 and 17
$Q_{\text{gs}1}$	Pre-V _{th} Gate-to-Source Charge	—	5.2	—		
$Q_{\text{gs}2}$	Post-V _{th} Gate-to-Source Charge	—	1.6	—		
Q_{gd}	Gate-to-Drain Charge	—	7.1	—		
Q_{godr}	Gate Charge Overdrive	—	7.1	—		
Q_{sw}	Switch Charge ($Q_{\text{gs}2} + Q_{\text{gd}}$)	—	8.7	—		
Q_{oss}	Output Charge	—	8.8	—	nC	$V_{\text{DS}} = 16\text{V}$, $V_{\text{GS}} = 0\text{V}$
$t_{\text{d(on)}}$	Turn-On Delay Time	—	10	—	ns	$V_{\text{DD}} = 75\text{V}$, $V_{\text{GS}} = 10\text{V}$ ⑦ $I_D = 11\text{A}$ $R_G = 6.8\Omega$
t_r	Rise Time	—	13	—		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	14	—		
t_f	Fall Time	—	7.5	—		
C_{iss}	Input Capacitance	—	1360	—	pF	$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = 25\text{V}$ $f = 1.0\text{MHz}$ $V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 1.0\text{V}$, $f = 1.0\text{MHz}$ $V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 120\text{V}$, $f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	190	—		
C_{rss}	Reverse Transfer Capacitance	—	41	—		
C_{oss}	Output Capacitance	—	1210	—		
C_{oss}	Output Capacitance	—	92	—		

Diode Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)

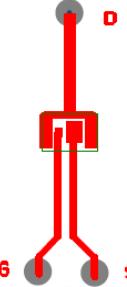
	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	18	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ⑤	—	—	72		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$, $I_S = 11\text{A}$, $V_{\text{GS}} = 0\text{V}$ ⑦
	Reverse Recovery Time	—	63	95		
Q_{rr}	Reverse Recovery Charge	—	180	270	nC	$T_J = 25^\circ\text{C}$, $I_F = 11\text{A}$, $V_{\text{DD}} = 25\text{V}$ $dI/dt = 100\text{A}/\mu\text{s}$ ⑦



⑦ Surface mounted on 1 in. square Cu (still air).



⑧ Mounted to a PCB with small clip heatsink (still air)



⑨ Mounted on minimum footprint full size board with metallized back and with small clip heatsink (still air)

Notes ① through ⑩ are on page 10

Qualification Information[†]

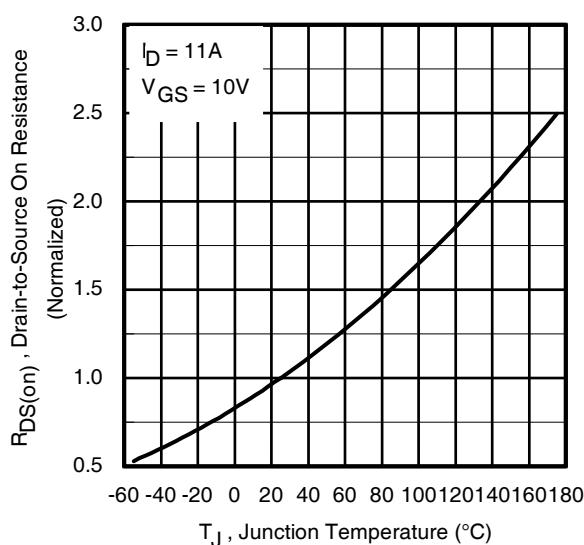
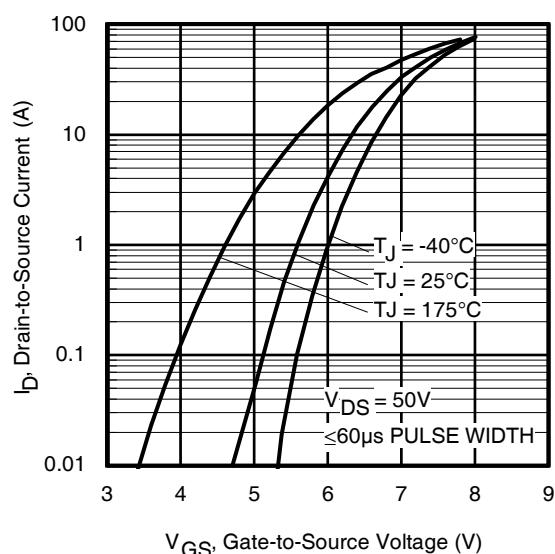
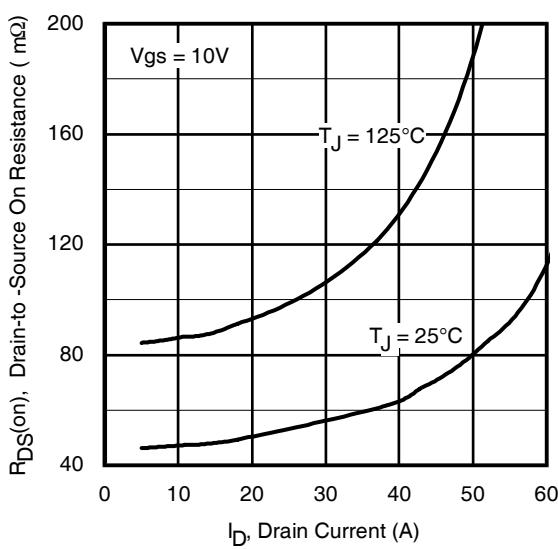
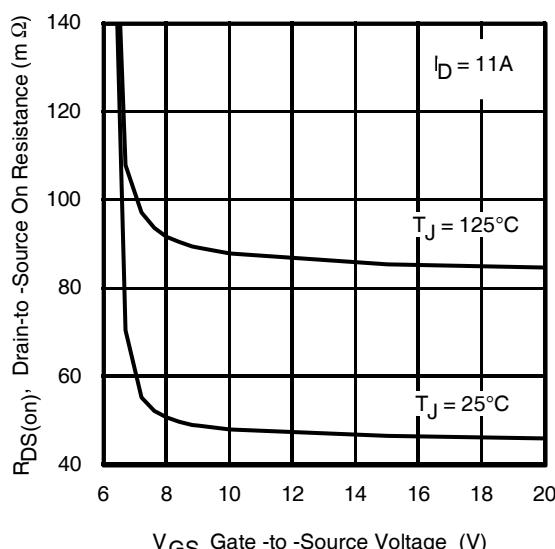
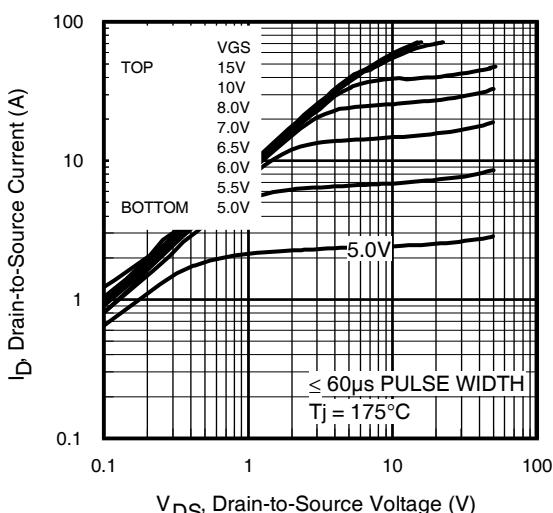
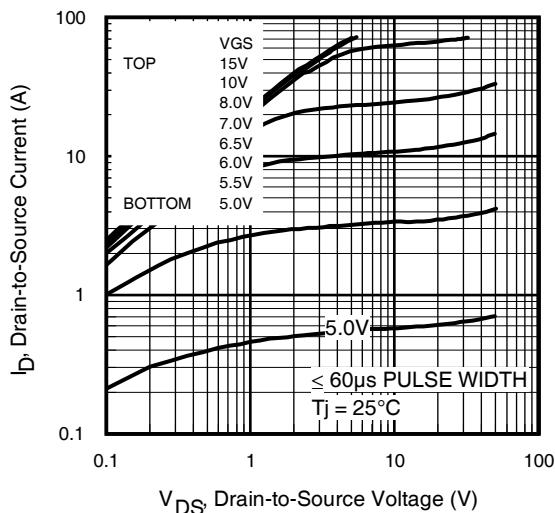
		Automotive (per AEC-Q101) ^{††}	
Qualification Level		Comments: This product has passed an Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
Moisture Sensitivity Level		SMALL CAN	MSL1, 260°C
ESD	Machine Model	Class M4 (+/-400V) AEC-Q101-002	
	Human Body Model	Class H1B (+/-1000V) AEC-Q101-001	
	Charged Device Model	Class HC4 (+/-1000V) AEC-Q101-005	
RoHS Compliant		Yes	

[†] Qualification standards can be found at International Rectifier's web site: <http://www.irf.com>

^{††} Exceptions to AEC-Q101 requirements are noted in the qualification report.

AUIRF7675M2TR/TR1

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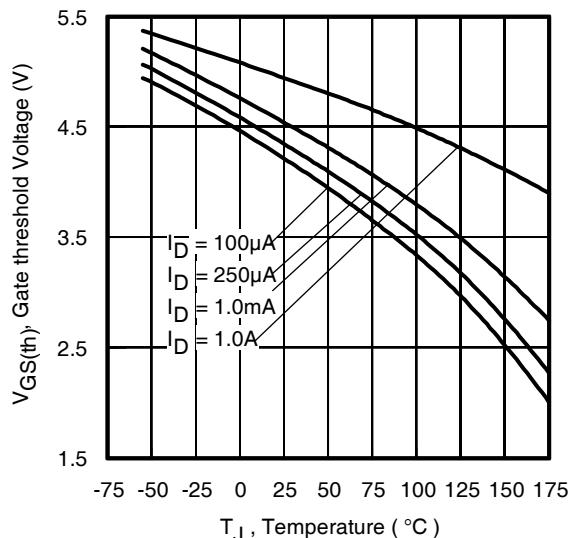


Fig 7. Typical Threshold Voltage vs. Junction Temperature

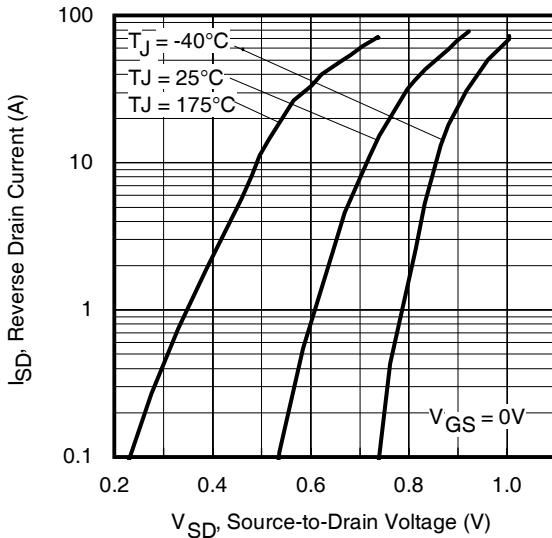


Fig 8. Typical Source-Drain Diode Forward Voltage

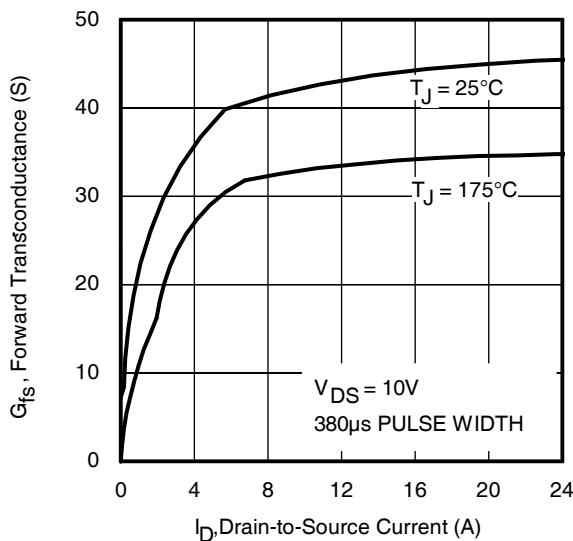


Fig 9. Typical Forward Transconductance Vs. Drain Current

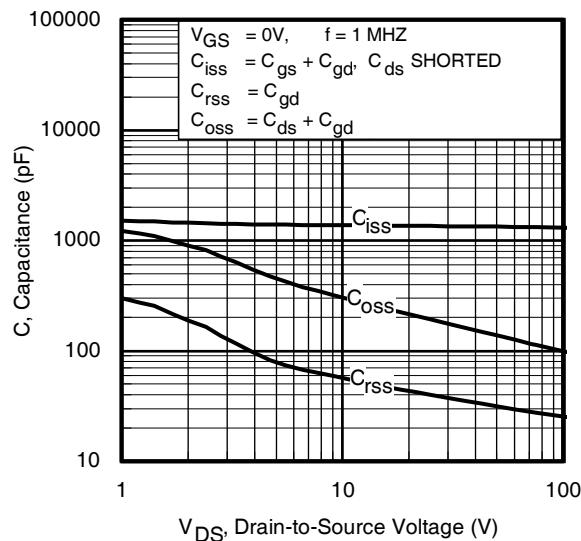


Fig 10. Typical Capacitance vs.Drain-to-Source Voltage

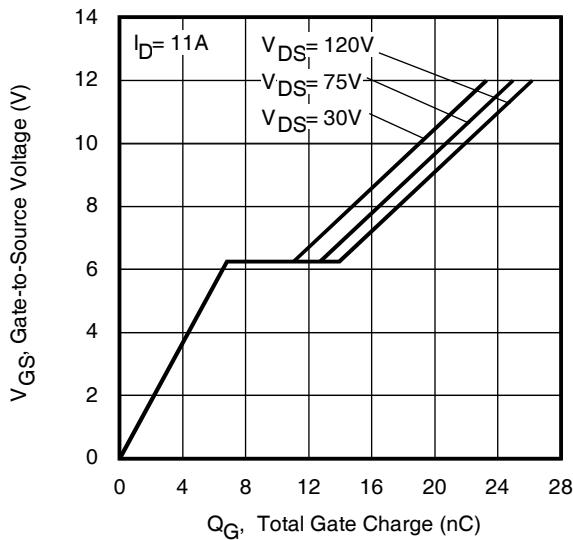


Fig.11 Typical Gate Charge vs.Gate-to-Source Voltage
www.irf.com

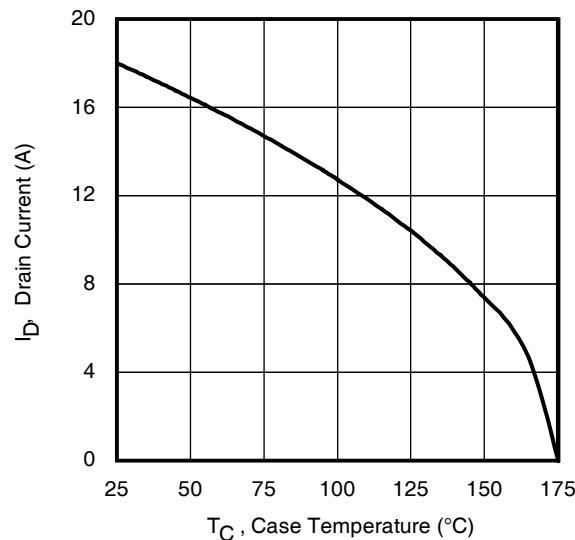


Fig 12. Maximum Drain Current vs. Case Temperature

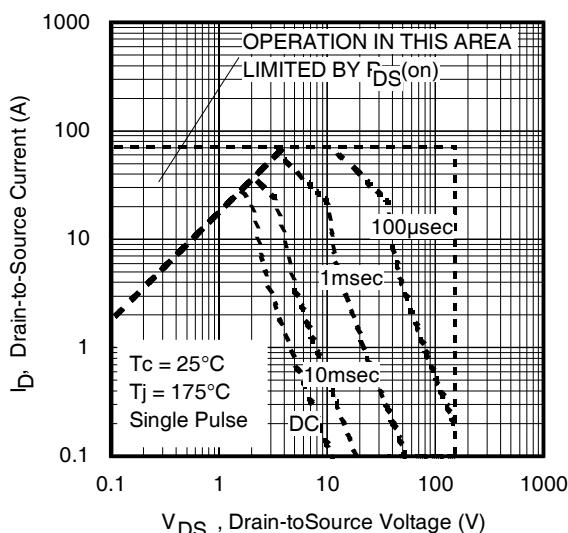


Fig 13. Maximum Safe Operating Area

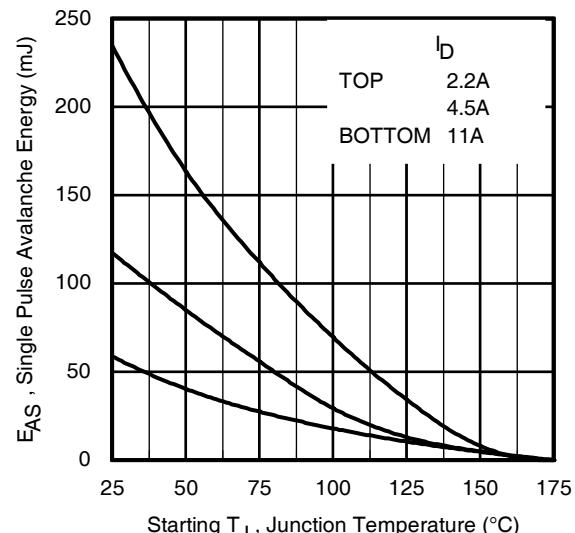


Fig 14. Maximum Avalanche Energy vs. Temperature

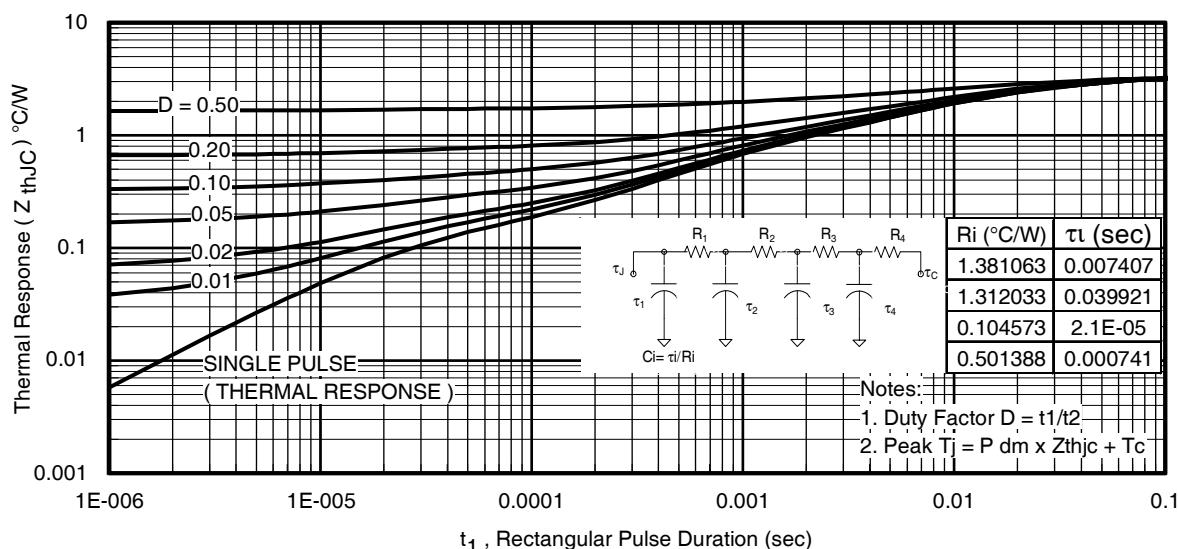


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

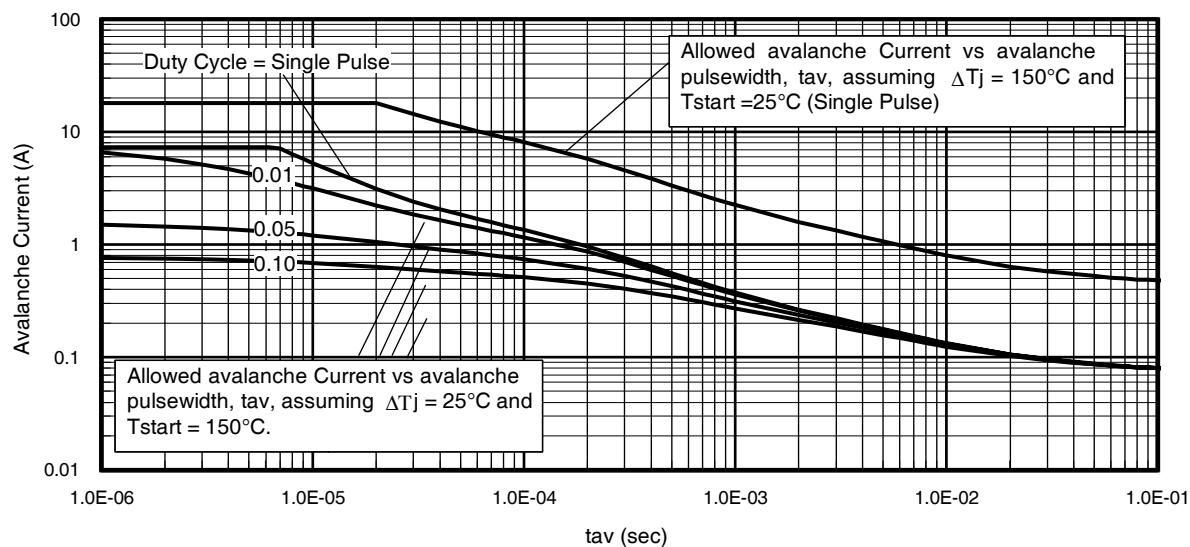


Fig 16. Typical Avalanche Current Vs. Pulsewidth

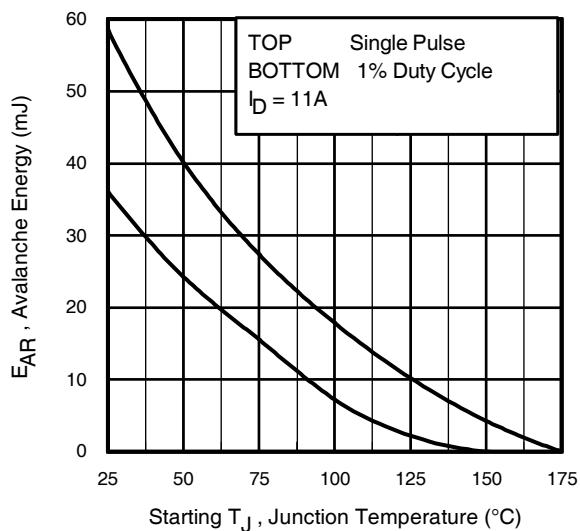


Fig 17. Maximum Avalanche Energy Vs. Temperature

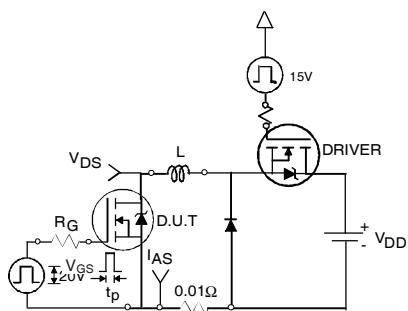


Fig 18a. Unclamped Inductive Test Circuit

Notes on Repetitive Avalanche Curves , Figures 16, 17:
(For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:
Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
4. $P_D(\text{ave})$ = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6. I_{av} = Allowable avalanche current.
7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 16, 17).
 t_{av} = Average time in avalanche.
 D = Duty cycle in avalanche = $t_{av} \cdot f$
 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see figure 11

$$P_D(\text{ave}) = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_D(\text{ave}) \cdot t_{av}$$

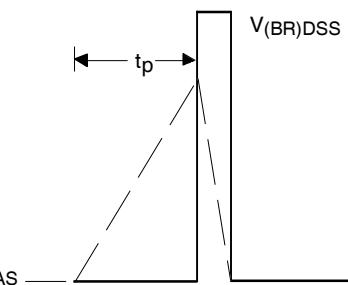


Fig 18b. Unclamped Inductive Waveforms

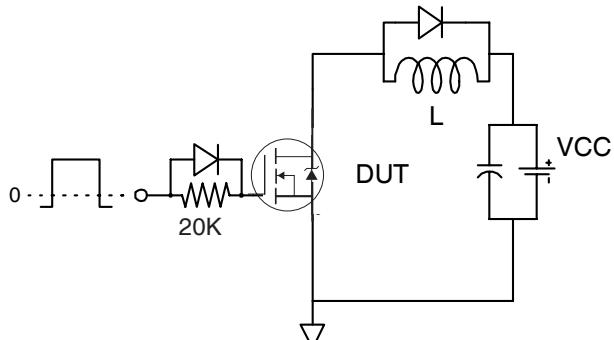


Fig 19a. Gate Charge Test Circuit

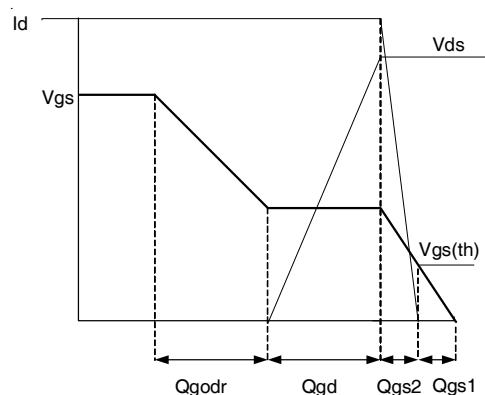


Fig 19b. Gate Charge Waveform

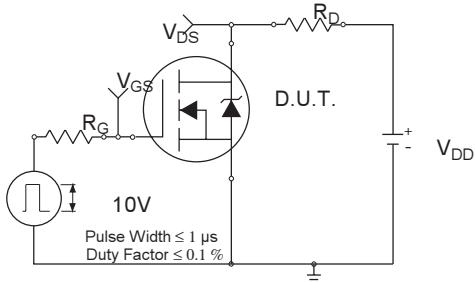


Fig 20a. Switching Time Test Circuit

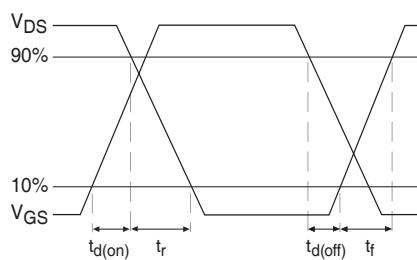
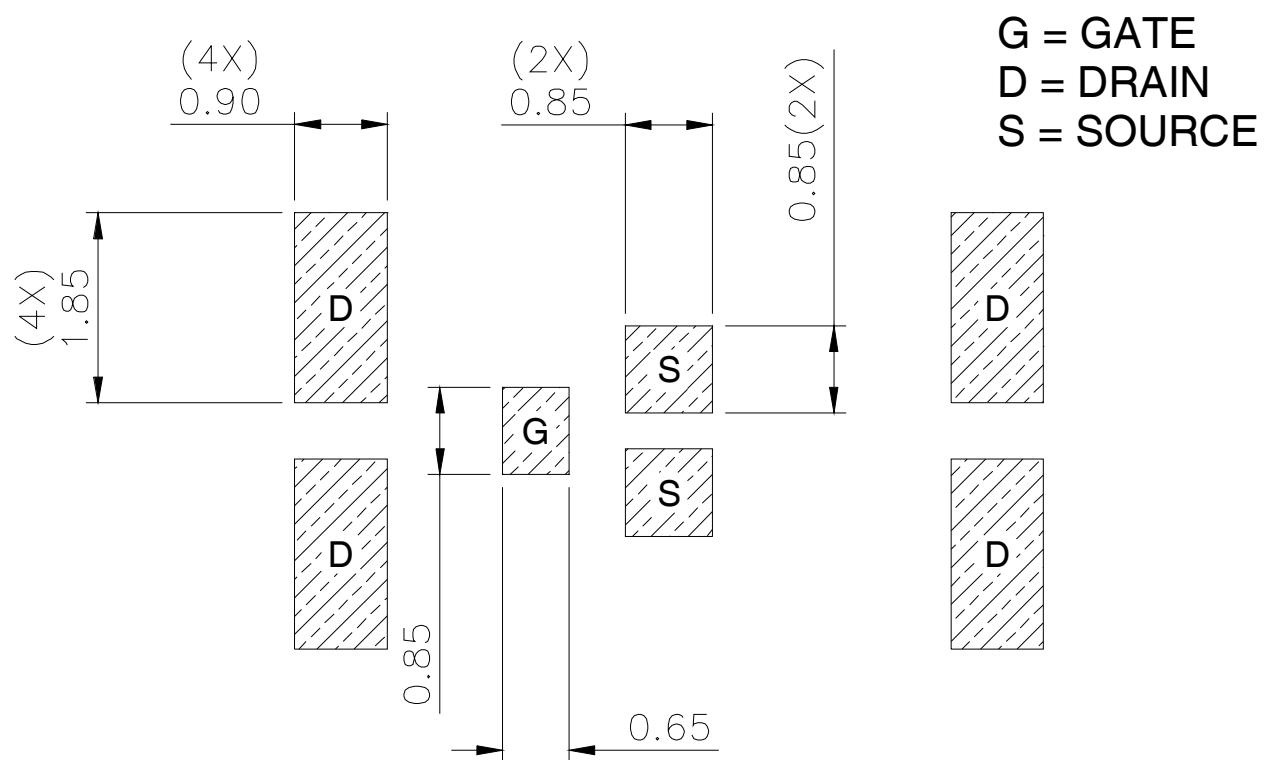
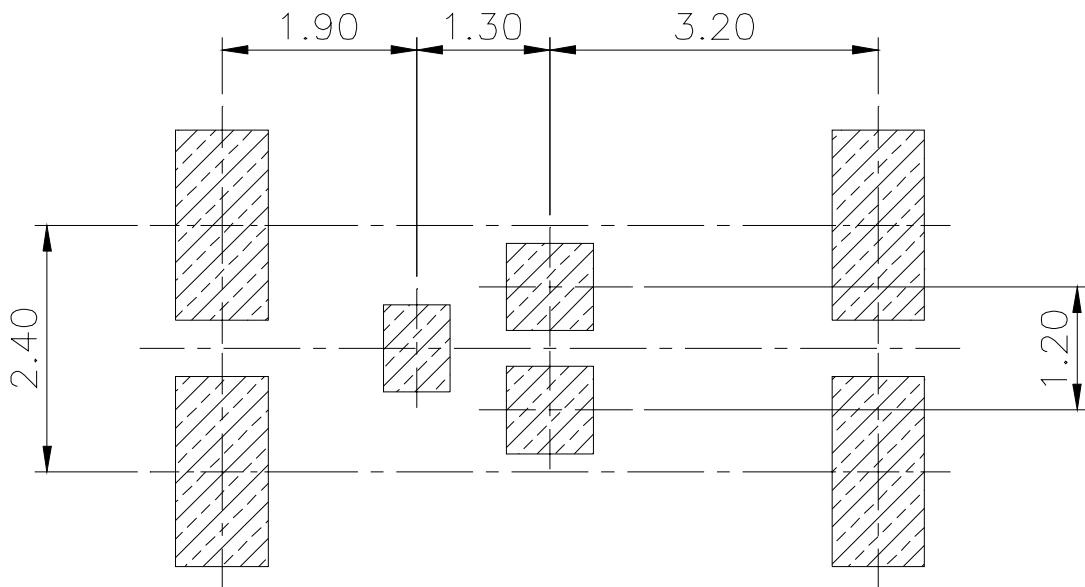


Fig 20b. Switching Time Waveforms

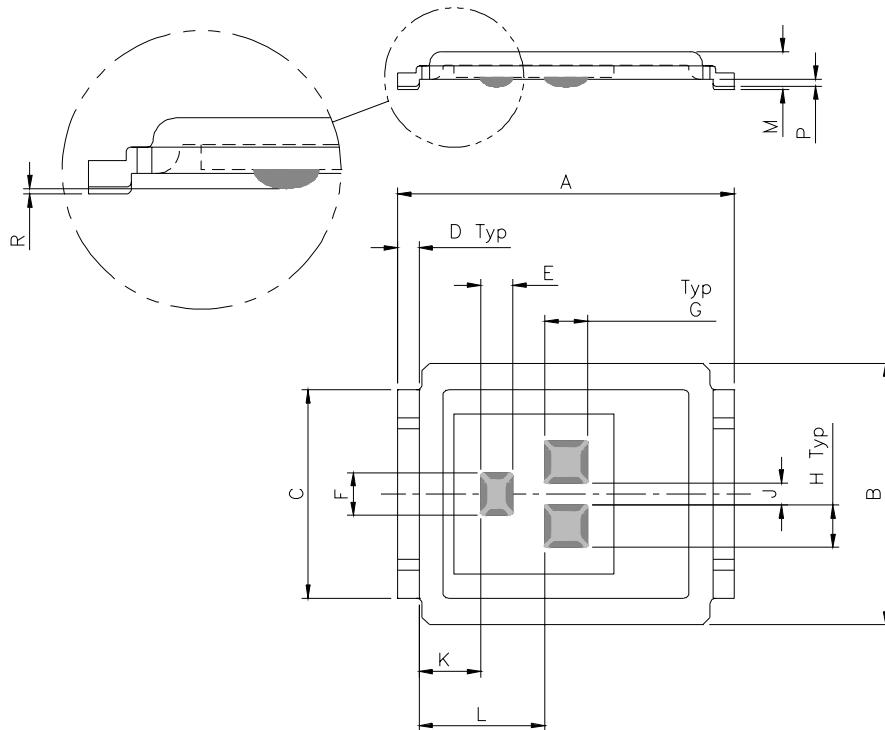
DirectFET™ Board Footprint, M2 (Medium Size Can).

Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations



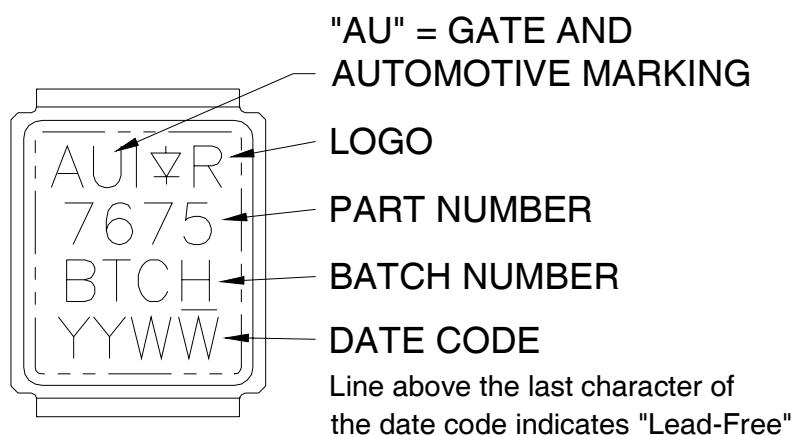
DirectFET™ Outline Dimension, M2 Outline (Medium Size Can).

Please see AN-1035 for DirectFET assembly details and stencil and substrate design recommendations

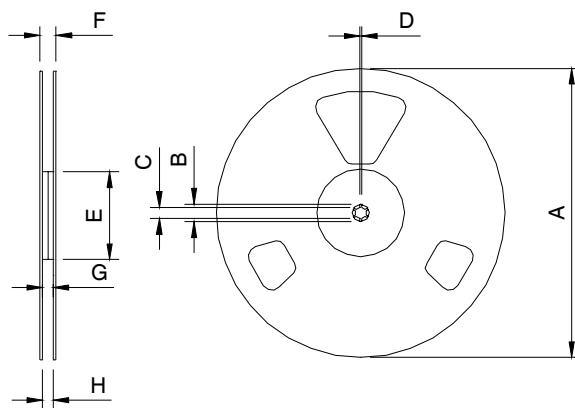


DIMENSIONS				
	METRIC		IMPERIAL	
CODE	MIN	MAX	MIN	MAX
A	6.25	6.35	0.246	0.250
B	4.80	5.05	0.189	0.201
C	3.85	3.95	0.152	0.156
D	0.35	0.45	0.014	0.018
E	0.58	0.62	0.023	0.024
F	0.78	0.82	0.031	0.032
G	0.78	0.82	0.031	0.032
H	0.78	0.82	0.031	0.032
I	N/A	N/A	N/A	N/A
J	0.38	0.42	0.015	0.017
K	1.10	1.20	0.043	0.047
L	2.30	2.40	0.090	0.094
M	0.68	0.74	0.027	0.029
P	0.09	0.17	0.003	0.007
R	0.02	0.08	0.001	0.003

DirectFET™ Part Marking



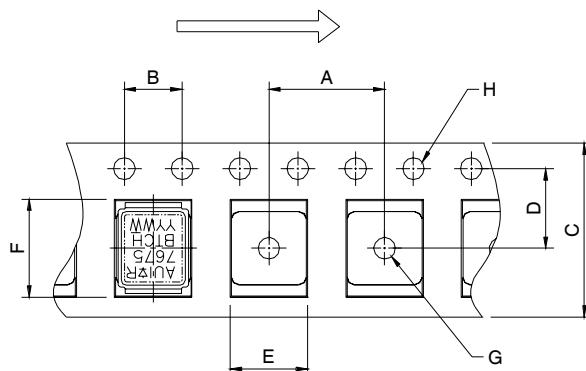
Automotive DirectFET™ Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm
Std reel quantity is 4800 parts. (ordered as AUIRF7675M2TR). For 1000 parts on 7" reel, order AUIRF7675M2TR1

REEL DIMENSIONS								
STANDARD OPTION (QTY 4800)				TR1 OPTION (QTY 1000)				
CODE	METRIC	MIN	MAX	IMPERIAL	METRIC	MIN	MAX	
A	330.0	N.C.	12.992		177.77	N.C.	6.9	N.C.
B	20.2	N.C.	0.795		19.06	N.C.	0.75	N.C.
C	12.8	13.2	0.504		13.5	12.8	0.53	0.50
D	1.5	N.C.	0.059		1.5	N.C.	0.059	N.C.
E	100.0	N.C.	3.937		58.72	N.C.	2.31	N.C.
F	N.C.	18.4	N.C.		N.C.	13.50	N.C.	0.53
G	12.4	14.4	0.488		11.9	12.01	0.47	N.C.
H	11.9	15.4	0.469		11.9	12.01	0.47	N.C.

LOADED TAPE FEED DIRECTION



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS				
CODE	METRIC		IMPERIAL	
	MIN	MAX	MIN	MAX
A	7.90	8.10	0.311	0.319
B	3.90	4.10	0.154	0.161
C	11.90	12.30	0.469	0.484
D	5.45	5.55	0.215	0.219
E	5.10	5.30	0.201	0.209
F	6.50	6.70	0.256	0.264
G	1.50	N.C.	0.059	N.C.
H	1.50	1.60	0.059	0.063

Notes:

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④ T_C measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.
- ⑥ Starting $T_J = 25^\circ\text{C}$, $L = 1.33\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 11\text{A}$.
- ⑦ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ⑧ Used double sided cooling, mounting pad with large heatsink.
- ⑨ Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- ⑩ R_θ is measured at T_J of approximately 90°C .

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